

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/894,128	YU, WEI-CHE	
Examiner		Art Unit		Page 1 of 1
Asghar Bilgrami		2143		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,618,755 B1	09-2003	Bonn, David Wayne	709/223
	B	US-6,839,751 B1	01-2005	Dietz et al.	709/224
	C	US-6,269,099 B1	07-2001	Borella et al.	370/389
	D	US-2002/0032769 A1	03-2002	Barkai et al.	709/224
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
1	U	Hwa-Chin Lin, 1998, IEEE, 0-7803-4788-9/98
2	V	RFC 768
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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